

# IRF623-VB Datasheet N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	200				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0. 91				
Q <sub>g</sub> (Max.) (nC)	13				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	7.9				
Configuration	Single				

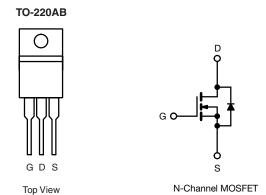
## **FEATURES**



- Trench Power MOSFET
- 175 °C Junction Temperature
- PWM Optimized
- 100 % R<sub>a</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

## **APPLICATIONS**

· Primary Side Switch



PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	200	V	
Gate-Source Voltage			$V_{GS}$	± 20	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	L	5.0		
	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	4.0	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	20		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) e				0.020	VV/ C	
Single Pulse Avalanche Energy b			E <sub>AS</sub>	161	mJ	
Repetitive Avalanche Current a			I <sub>AR</sub>	4.8	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	T <sub>C</sub> = 25 °C		42	W	
Maximum Power Dissipation (PCB mount) e	T <sub>A</sub> =	T <sub>A</sub> = 25 °C		P <sub>D</sub> 2.5		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	ာင	
Soldering Recommendations (Peak temperature)	for 10 s			260		

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=50$  V, starting  $T_J=25$  °C, L=14 mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=4.8$  A (see fig. 12). c.  $I_{SD}\leq5.2$  A,  $dI/dt\leq95$  A/ $\mu$ s,  $V_{DD}\leq V_{DS}$ ,  $T_J\leq150$  °C.

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110		
Maximum Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	50	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							l
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.29	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
- 0.1111 - 0.10		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V		-	-	25	_
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 160 V	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.9 A <sup>b</sup>	-	0.91	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 2.9 A <sup>b</sup>	1.7	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	185	-	pF
Output Capacitance	C <sub>oss</sub>		$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		100	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	30	-	
Total Gate Charge	Qg			-	-	13.0	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 b		-	3.0	nC
Gate-Drain Charge	Q <sub>gd</sub>	See lig. 6 and 13		-	-	7.9	
Turn-On Delay Time	t <sub>d(on)</sub>				7.2	-	- ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 100 V, $I_D$ = 4.8 A, $R_G$ = 18 $\Omega$ , $R_D$ = 20 $\Omega$ , see fig. 10 <sup>b</sup>		-	22	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	19	-	
Fall Time	t <sub>f</sub>				13	-	
Internal Drain Inductance	$L_D$	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	11111
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.8	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	19	
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 4.8  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.8 A, dl/dt = 100 A/μs b		-	150	300	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.91	1.8	μC
Forward Turn-On Time	t <sub>on</sub> Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )						L <sub>D</sub> )

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

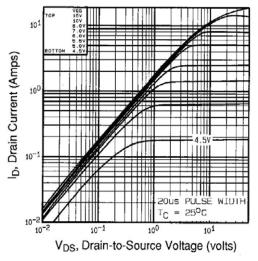


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

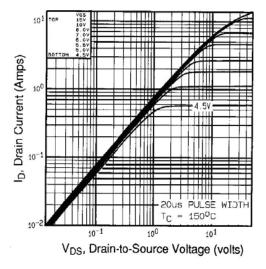


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

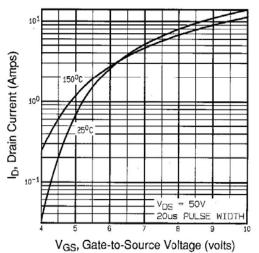


Fig. 3 - Typical Transfer Characteristics

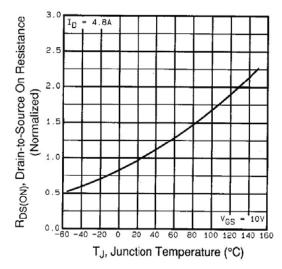


Fig. 4 - Normalized On-Resistance vs. Temperature



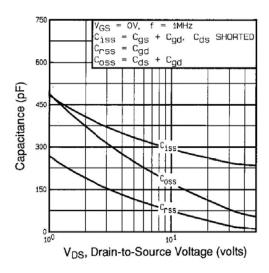


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

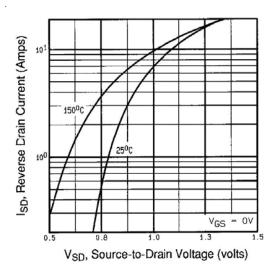


Fig. 7 - Typical Source-Drain Diode Forward Voltage

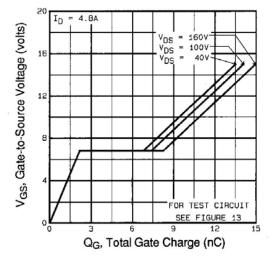


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

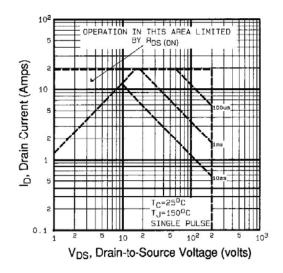


Fig. 8 - Maximum Safe Operating Area



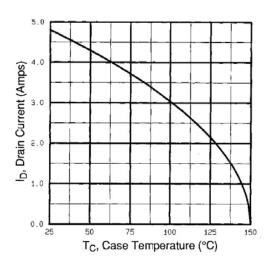


Fig. 9 - Maximum Drain Current vs. Case Temperature

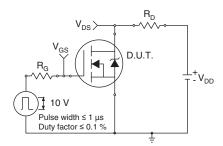


Fig. 10a - Switching Time Test Circuit

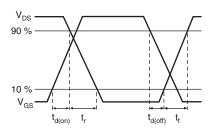


Fig. 10b - Switching Time Waveforms

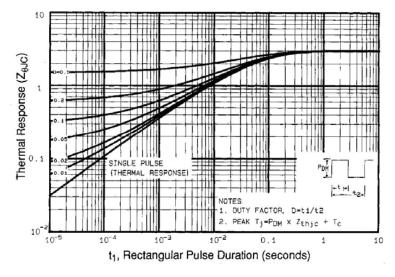


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



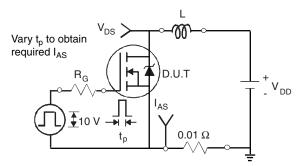


Fig. 12a - Unclamped Inductive Test Circuit

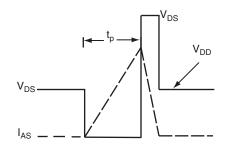


Fig. 12b - Unclamped Inductive Waveforms

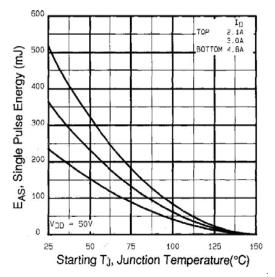


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

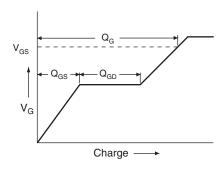


Fig. 13a - Basic Gate Charge Waveform

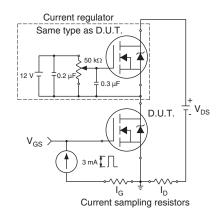
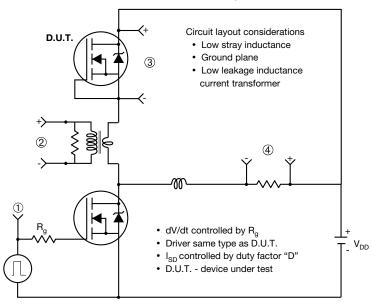


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



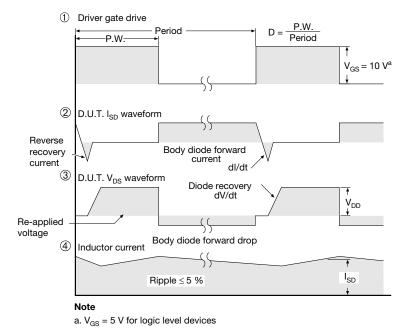
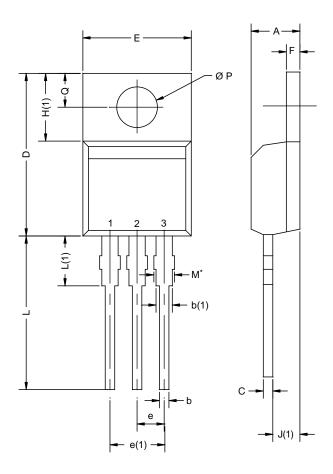


Fig. 14 - For N-Channel



# **TO-220AB**



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

#### Notes

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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